

Partially reduced graphene/silicon interfaces via electrochemical reduction

Robertino Zanoni¹

Andrea G. Marrani,¹ E.A. Dalchiele², R. Schrebler³

¹ Dipartimento di Chimica, Università di Roma La Sapienza, piazzale Aldo Moro, 5, Rome, Italy

² Instituto de Física & CINQUIFIMA, Facultad de Ingeniería, Julio Herrera y Reissig 565, C.C. 30, 11000 Montevideo, Uruguay

³ Instituto de Química, Facultad de Ciencias, Pontificia Universidad Católica de Valparaíso, Av. Brasil 2950, Valparaíso, Chile

robertino.zanoni@uniroma1.it

Abstract

The relatively recent progresses in the characterization of true graphene deposits have allowed a much better interpretation of results in the field, also allowing for a comparison between the outcomes of distinct synthetic strategies aimed at partially reduced forms of graphene oxide.[1,2] A notable goal in view of studies and applications of graphene is the obtainment of handy forms of this material, allowing for developments in real conditions. To achieve applications, a large-scale production of high quality graphene sheets in an efficient and effective way is required.[3]

Wafer-scale integration of reduced graphene oxide with H-terminated Si[111] surfaces has been recently accomplished by electrochemical reduction of a thin film of graphene oxide deposited onto Si by drop casting.[4,5] Distinct reduction methods have been assayed and carried out in solution. The resulting interface has been characterized in its surface composition, morphology and electrochemical behavior by X-ray photoelectron spectroscopy, Raman spectroscopy, atomic force microscopy and electrochemical measurements. The results evidence that few-layer graphene deposits on H-Si[111] were obtained after reduction, with a very limited surface oxidation of the Si substrate and a very low oxygen-to-carbon ratio. The described approach is fast, simple, economic, scalable and straightforward, as one reduction cycle is already effective in promoting the establishment of a graphene-Si interface. It avoids thermal treatments at high temperatures, use of aggressive chemicals and the presence of metal contaminants, and enables preservation of Si[111] surface from oxidation. This may favour applications in biomedicine, rapidly growing in number and importance in the last few years.[6]

References

- [1] S. C. Ray, 'Applications of Graphene and Graphene-Oxide Based Nanomaterials'; William Andrew Publishing: Oxford, 2015; pp 1–38.
- [2] A.C. Ferrari, A. C.; Meyer, J. C.; Scardaci, V.; Casiraghi, C.; Lazzeri, M.; Mauri, F.; Piscanec, S.; Jiang, D.; Novoselov, K. S.; Roth, S.; et al., *Phys. Rev. Lett.* 97, 187401 [2006].
- [3] T. Kuila, S. Bose, A.K. Mishra, P. Khanra, N.H. Kim, J.H. Lee, *Prog. Mater. Sci.* 57, 1061–1105 [2012].
- [4] A.G. Marrani, R. Zanoni, R. Schrebler, E.A. Dalchiele, 'Toward Graphene/Silicon Interface via Controlled Electrochemical Reduction of Graphene Oxide', *J. Phys. Chem. C.* 121 5675–5683 [2017].
- [5] A.G. Marrani, A.C. Coico, D. Giacco, R. Zanoni, F.A. Scaramuzza, R. Schrebler, D. Dini, M. Bonomo, E. A. Dalchiele, 'Integration of graphene onto silicon through electrochemical reduction of graphene oxide layers in non-aqueous medium', *Appl. Surf. Sci.* 445, 404–414 [2018].
- [6] S. Kumar and K. Chatterjee, 'Comprehensive Review on the Use of Graphene-Based Substrates for Regenerative Medicine and Biomedical Devices', *ACS Appl. Mater. Interfaces*, 8, 26431–26457 [2016].